

MOSFETs Silicon P-/N-Channel MOS

# SSM6L807R

## 1. Applications

- Power Management Switches

## 2. Features

- (1) Low drain-source on-resistance

Q1 N-channel:

$$R_{DS(ON)} = 39.1 \text{ m}\Omega \text{ (max) (@}V_{GS} = 4.5 \text{ V)}$$

$$R_{DS(ON)} = 53 \text{ m}\Omega \text{ (max) (@}V_{GS} = 2.5 \text{ V)}$$

$$R_{DS(ON)} = 82 \text{ m}\Omega \text{ (max) (@}V_{GS} = 1.8 \text{ V)}$$

Q2 P-channel:

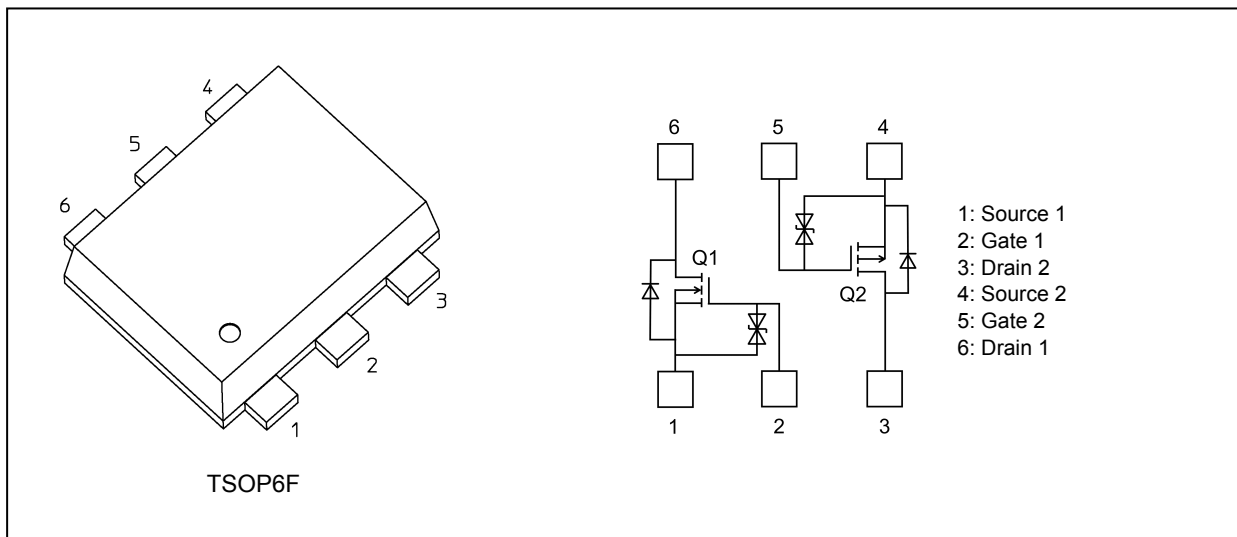
$$R_{DS(ON)} = 45 \text{ m}\Omega \text{ (max) (@}V_{GS} = -10 \text{ V)}$$

$$R_{DS(ON)} = 56 \text{ m}\Omega \text{ (max) (@}V_{GS} = -4.5 \text{ V)}$$

$$R_{DS(ON)} = 76 \text{ m}\Omega \text{ (max) (@}V_{GS} = -2.5 \text{ V)}$$

$$R_{DS(ON)} = 157 \text{ m}\Omega \text{ (max) (@}V_{GS} = -1.8 \text{ V)}$$

## 3. Packaging and Internal Circuit



Start of commercial production  
2018-11

### 4. Absolute Maximum Ratings (Note)

#### 4.1. Q1 Absolute Maximum Ratings (Unless otherwise specified, $T_a = 25\text{ }^\circ\text{C}$ )

| Characteristics                           | Symbol    | Rating   | Unit |
|---|-----------|----------|------|
| Drain-source voltage                      | $V_{DSS}$ | 30       | V    |
| Gate-source voltage (Note 3)              | $V_{GSS}$ | $\pm 12$ | V    |
| Drain current (DC) (Note 1)               | $I_D$     | 4        | A    |
| Drain current (pulsed) (Note 1), (Note 2) | $I_{DP}$  | 10       |      |

Note 1: Ensure that the channel temperature does not exceed  $150\text{ }^\circ\text{C}$ .

Note 2: Pulse width (PW)  $\leq 10\text{ ms}$ , duty  $\leq 1\%$

Note 3: Reverse bias between gate and source is guaranteed with pulse rating.

#### 4.2. Q2 Absolute Maximum Ratings (Unless otherwise specified, $T_a = 25\text{ }^\circ\text{C}$ )

| Characteristics                           | Symbol    | Rating   | Unit |
|---|-----------|----------|------|
| Drain-source voltage                      | $V_{DSS}$ | -20      | V    |
| Gate-source voltage (Note 3)              | $V_{GSS}$ | $\pm 12$ | V    |
| Drain current (DC) (Note 1)               | $I_D$     | -4       | A    |
| Drain current (pulsed) (Note 1), (Note 2) | $I_{DP}$  | -10      |      |

Note 1: Ensure that the channel temperature does not exceed  $150\text{ }^\circ\text{C}$ .

Note 2: Pulse width (PW)  $\leq 10\text{ ms}$ , duty  $\leq 1\%$

Note 3: Reverse bias between gate and source is guaranteed with pulse rating.

#### 4.3. Absolute Maximum Ratings (Unless otherwise specified, $T_a = 25\text{ }^\circ\text{C}$ ) (Q1, Q2 Common)

| Characteristics                                 | Symbol    | Rating     | Unit             |
|---|-----------|------------|------------------|
| Power dissipation (Note 1)                      | $P_D$     | 1.4        | W                |
| Power dissipation $t \leq 10\text{ s}$ (Note 1) |           | 1.8        |                  |
| Channel temperature                             | $T_{ch}$  | 150        | $^\circ\text{C}$ |
| Storage temperature                             | $T_{stg}$ | -55 to 150 | $^\circ\text{C}$ |

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Note 1: Device mounted on an FR4 board.( $25.4\text{ mm} \times 25.4\text{ mm} \times 1.6\text{ mm}$ , Cu pad:  $645\text{ mm}^2$ )

Note: The MOSFETs in this device are sensitive to electrostatic discharge. When handling this device, the worktables, operators, soldering irons and other objects should be protected against anti-static discharge.

Note: The channel-to-ambient thermal resistance,  $R_{th(ch-a)}$ , and the drain power dissipation,  $P_D$ , vary according to the board material, board area, board thickness and pad area. When using this device, be sure to take heat dissipation fully into account.

### 5. Thermal Characteristics

| Characteristics                                | Symbol         | Max | Unit               |
|--|----------------|-----|--------------------|
| Channel-to-ambient thermal resistance (Note 1) | $R_{th(ch-a)}$ | 89  | $^\circ\text{C/W}$ |

Note 1: Device mounted on an FR4 board.( $25.4\text{ mm} \times 25.4\text{ mm} \times 1.6\text{ mm}$ , Cu pad:  $645\text{ mm}^2$ )

### 6. Electrical Characteristics

#### 6.1. Q1 Static Characteristics (Unless otherwise specified, $T_a = 25\text{ }^\circ\text{C}$ )

| Characteristics                         | Symbol        | Test Condition                                  | Min | Typ. | Max      | Unit          |
|---|---------------|---|-----|------|----------|---------------|
| Gate leakage current                    | $I_{GSS}$     | $V_{DS} = 0\text{ V}, V_{GS} = \pm 10\text{ V}$ | —   | —    | $\pm 10$ | $\mu\text{A}$ |
| Drain cut-off current                   | $I_{DSS}$     | $V_{DS} = 24\text{ V}, V_{GS} = 0\text{ V}$     | —   | —    | 1        | $\mu\text{A}$ |
| Drain-source breakdown voltage          | $V_{(BR)DSS}$ | $I_D = 1\text{ mA}, V_{GS} = 0\text{ V}$        | 30  | —    | —        | V             |
| Drain-source breakdown voltage (Note 1) | $V_{(BR)DSX}$ | $I_D = 1\text{ mA}, V_{GS} = -12\text{ V}$      | 18  | —    | —        | V             |
| Gate threshold voltage (Note 2)         | $V_{th}$      | $V_{DS} = 3\text{ V}, I_D = 1\text{ mA}$        | 0.4 | —    | 1.0      | V             |
| Drain-source on-resistance (Note 3)     | $R_{DS(ON)}$  | $I_D = 2.0\text{ A}, V_{GS} = 4.5\text{ V}$     | —   | 30   | 39.1     | m $\Omega$    |
|   |               | $I_D = 1.0\text{ A}, V_{GS} = 2.5\text{ V}$     | —   | 37   | 53       |               |
|   |               | $I_D = 0.5\text{ A}, V_{GS} = 1.8\text{ V}$     | —   | 46   | 82       |               |

Note 1: If a reverse bias is applied between gate and source, this device enters  $V_{(BR)DSX}$  mode. Note that the drain-source breakdown voltage is lowered in this mode.

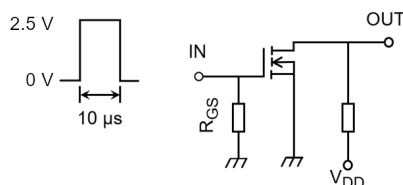
Note 2: Let  $V_{th}$  be the voltage applied between gate and source that causes the drain current ( $I_D$ ) to below (1 mA for this device). Then, for normal switching operation,  $V_{GS(ON)}$  must be higher than  $V_{th}$ , and  $V_{GS(OFF)}$  must be lower than  $V_{th}$ . This relationship can be expressed as:  $V_{GS(OFF)} < V_{th} < V_{GS(ON)}$ . Take this into consideration when using the device.

Note 3: Pulse measurement.

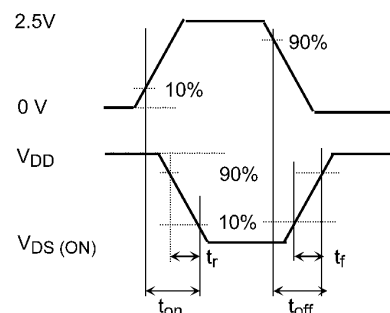
#### 6.2. Q1 Dynamic Characteristics (Unless otherwise specified, $T_a = 25\text{ }^\circ\text{C}$ )

| Characteristics                | Symbol    | Test Condition   | Min | Typ. | Max | Unit |
|--------------------------------|-----------|--|-----|------|-----|------|
| Input capacitance              | $C_{iss}$ | $V_{DS} = 15\text{ V}, V_{GS} = 0\text{ V},$<br>$f = 1\text{ MHz}$   | —   | 310  | —   | pF   |
| Reverse transfer capacitance   | $C_{rss}$ |  | —   | 20   | —   |      |
| Output capacitance             | $C_{oss}$ |  | —   | 52   | —   |      |
| Switching time (turn-on time)  | $t_{on}$  | $V_{DD} = 15\text{ V}, I_D = 1.0\text{ A},$<br>$V_{GS} = 0\text{ to } 2.5\text{ V}, R_{GS} = 4.7\text{ }\Omega$<br>Duty $\leq 1\%$ , Input: $t_r, t_f < 5\text{ ns}$<br>Common source, See Chapter 6.3 | —   | 26   | —   | ns   |
| Switching time (turn-off time) | $t_{off}$ |  | —   | 17   | —   |      |

#### 6.3. Q1 Switching Time Test Circuit



Switching Time Test Circuit



Input Waveform/Output Waveform

#### 6.4. Q1 Gate Charge Characteristics (Unless otherwise specified, $T_a = 25\text{ }^\circ\text{C}$ )

| Characteristics                                 | Symbol    | Test Condition   | Min | Typ. | Max | Unit |
|---|-----------|--|-----|------|-----|------|
| Total gate charge (gate-source plus gate-drain) | $Q_g$     | $V_{DD} = 15\text{ V}, I_D = 4.0\text{ A},$<br>$V_{GS} = 4.5\text{ V}$ | —   | 3.2  | —   | nC   |
| Gate-source charge 1                            | $Q_{gs1}$ |  | —   | 0.5  | —   |      |
| Gate-drain charge                               | $Q_{gd}$  |  | —   | 0.7  | —   |      |

### 6.5. Q1 Source-Drain Characteristics (Unless otherwise specified, $T_a = 25\text{ }^\circ\text{C}$ )

| Characteristics                | Symbol    | Test Condition                                  | Min | Typ. | Max | Unit |
|--------------------------------|-----------|---|-----|------|-----|------|
| Diode forward voltage (Note 1) | $V_{DSF}$ | $I_{DR} = 4.0\text{ A}$ , $V_{GS} = 0\text{ V}$ | —   | 0.8  | 1.2 | V    |

Note 1: Pulse measurement.

### 6.6. Q2 Static Characteristics (Unless otherwise specified, $T_a = 25\text{ }^\circ\text{C}$ )

| Characteristics                         | Symbol        | Test Condition                                     | Min  | Typ. | Max     | Unit          |
|---|---------------|--|------|------|---------|---------------|
| Gate leakage current                    | $I_{GSS}$     | $V_{DS} = 0\text{ V}$ , $V_{GS} = \pm 10\text{ V}$ | —    | —    | $\pm 1$ | $\mu\text{A}$ |
| Drain cut-off current                   | $I_{DSS}$     | $V_{DS} = -20\text{ V}$ , $V_{GS} = 0\text{ V}$    | —    | —    | -1      | $\mu\text{A}$ |
| Drain-source breakdown voltage          | $V_{(BR)DSS}$ | $I_D = -1\text{ mA}$ , $V_{GS} = 0\text{ V}$       | -20  | —    | —       | V             |
| Drain-source breakdown voltage (Note 1) | $V_{(BR)DSX}$ | $I_D = -1\text{ mA}$ , $V_{GS} = 8\text{ V}$       | -12  | —    | —       | V             |
| Gate threshold voltage (Note 2)         | $V_{th}$      | $V_{DS} = -3\text{ V}$ , $I_D = -1\text{ mA}$      | -0.5 | —    | -1.2    | V             |
| Drain-source on-resistance (Note 3)     | $R_{DS(ON)}$  | $I_D = -3.5\text{ A}$ , $V_{GS} = -10\text{ V}$    | —    | 36   | 45      | m $\Omega$    |
|   |               | $I_D = -3.0\text{ A}$ , $V_{GS} = -4.5\text{ V}$   | —    | 44   | 56      |               |
|   |               | $I_D = -2.0\text{ A}$ , $V_{GS} = -2.5\text{ V}$   | —    | 60   | 76      |               |
|   |               | $I_D = -0.5\text{ A}$ , $V_{GS} = -1.8\text{ V}$   | —    | 83   | 157     |               |

Note 1: If a reverse bias is applied between gate and source, this device enters  $V_{(BR)DSX}$  mode. Note that the drain-source breakdown voltage is lowered in this mode.

Note 2: Let  $V_{th}$  be the voltage applied between gate and source that causes the drain current ( $I_D$ ) to below (-1 mA for this device). Then, for normal switching operation,  $V_{GS(ON)}$  must be higher than  $V_{th}$ , and  $V_{GS(OFF)}$  must be lower than  $V_{th}$ . This relationship can be expressed as:  $V_{GS(OFF)} < V_{th} < V_{GS(ON)}$ .

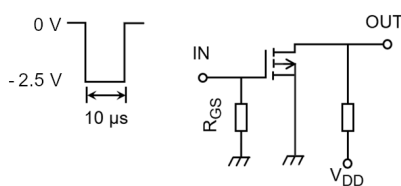
Take this into consideration when using the device.

Note 3: Pulse measurement.

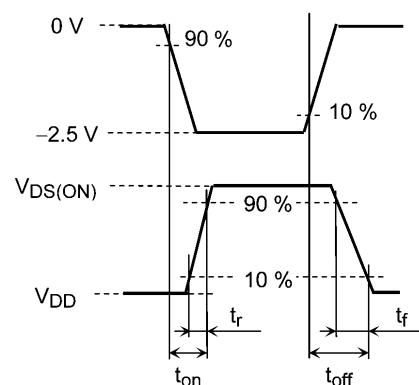
### 6.7. Q2 Dynamic Characteristics (Unless otherwise specified, $T_a = 25\text{ }^\circ\text{C}$ )

| Characteristics                | Symbol    | Test Condition  | Min | Typ. | Max | Unit |
|--------------------------------|-----------|---|-----|------|-----|------|
| Input capacitance              | $C_{iss}$ | $V_{DS} = -10\text{ V}$ , $V_{GS} = 0\text{ V}$ ,<br>$f = 1\text{ MHz}$   | —   | 480  | —   | pF   |
| Reverse transfer capacitance   | $C_{rss}$ |   | —   | 76   | —   |      |
| Output capacitance             | $C_{oss}$ |   | —   | 90   | —   |      |
| Switching time (turn-on time)  | $t_{on}$  | $V_{DD} = -10\text{ V}$ , $I_D = -0.5\text{ A}$ ,<br>$V_{GS} = 0$ to $-2.5\text{ V}$ , $R_{GS} = 4.7\text{ }\Omega$<br>Duty $\leq 1\%$ , $V_{IN}$ : $t_r$ , $t_f < 5\text{ ns}$ ,<br>Common source, See Chapter 6.8 | —   | 21   | —   | ns   |
| Switching time (turn-off time) | $t_{off}$ |   | —   | 54   | —   |      |

### 6.8. Q2 Switching Time Test Circuit



Switching Time Test Circuit



Input Waveform/Output Waveform

### 6.9. Q2 Gate Charge Characteristics (Unless otherwise specified, $T_a = 25\text{ }^\circ\text{C}$ )

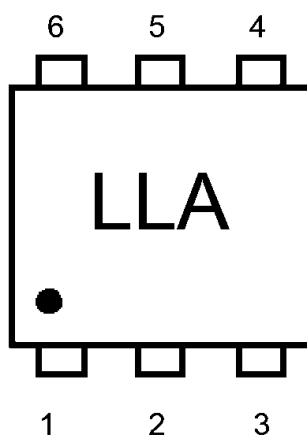
| Characteristics                                 | Symbol    | Test Condition  | Min | Typ. | Max | Unit |
|---|-----------|---|-----|------|-----|------|
| Total gate charge (gate-source plus gate-drain) | $Q_g$     | $V_{DD} = -10\text{ V}$ , $I_D = -4.0\text{ A}$ ,<br>$V_{GS} = -4.5\text{ V}$ | —   | 6.74 | —   | nC   |
| Gate-source charge 1                            | $Q_{gs1}$ |   | —   | 0.95 | —   |      |
| Gate-drain charge                               | $Q_{gd}$  |   | —   | 1.50 | —   |      |

### 6.10. Q2 Source-Drain Characteristics (Unless otherwise specified, $T_a = 25\text{ }^\circ\text{C}$ )

| Characteristics                | Symbol    | Test Condition                                  | Min | Typ. | Max | Unit |
|--------------------------------|-----------|---|-----|------|-----|------|
| Diode forward voltage (Note 1) | $V_{DSF}$ | $I_{DR} = 4.0\text{ A}$ , $V_{GS} = 0\text{ V}$ | —   | 0.87 | 1.2 | V    |

Note 1: Pulse measurement.

## 7. Marking



Marking

## 8. Characteristics Curves (Note)

### 8.1. Q1 Characteristics Curves

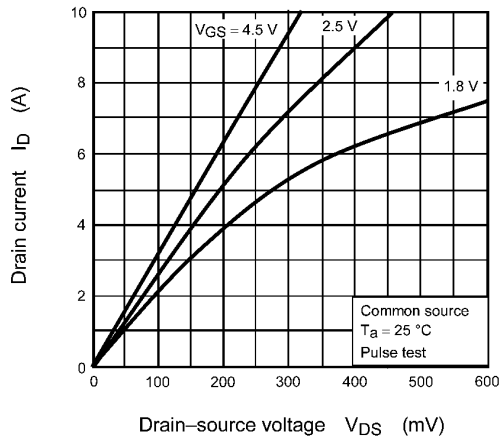


Fig. 8.1.1  $I_D - V_{DS}$

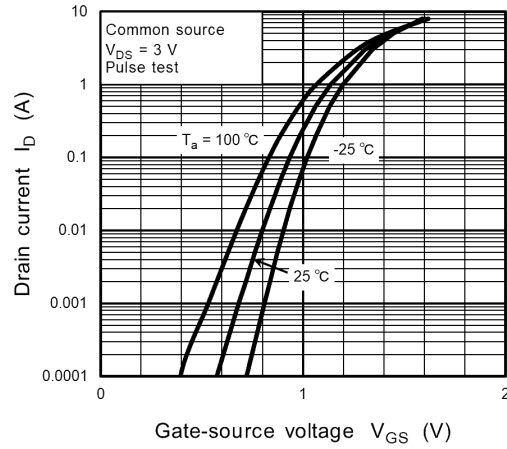


Fig. 8.1.2  $I_D - V_{GS}$

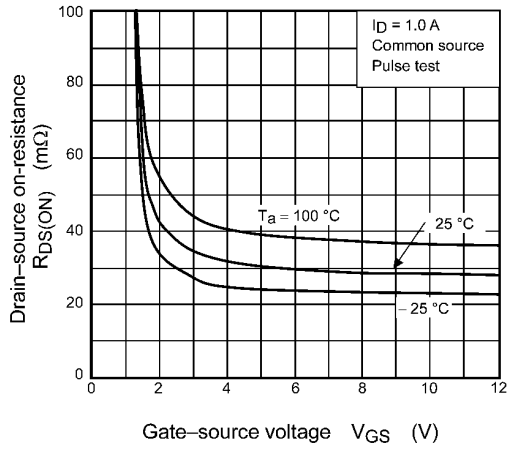


Fig. 8.1.3  $R_{DS(ON)} - V_{GS}$

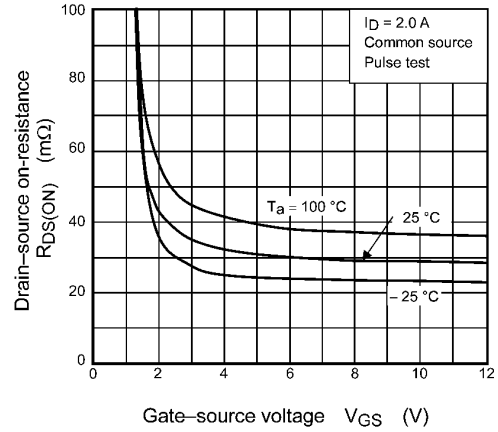


Fig. 8.1.4  $R_{DS(ON)} - V_{GS}$

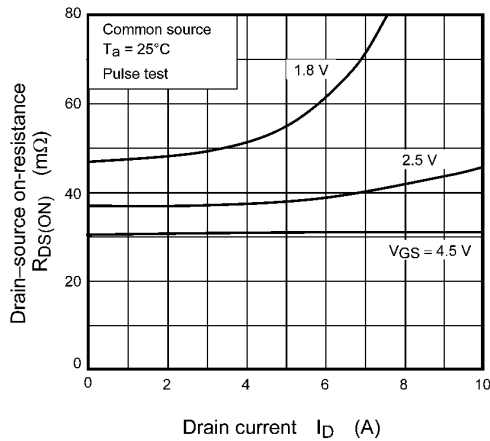


Fig. 8.1.5  $R_{DS(ON)} - I_D$

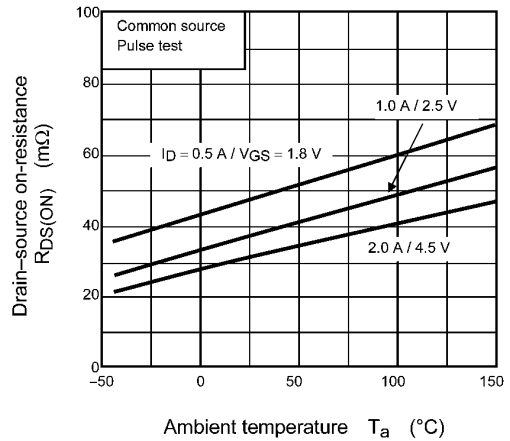
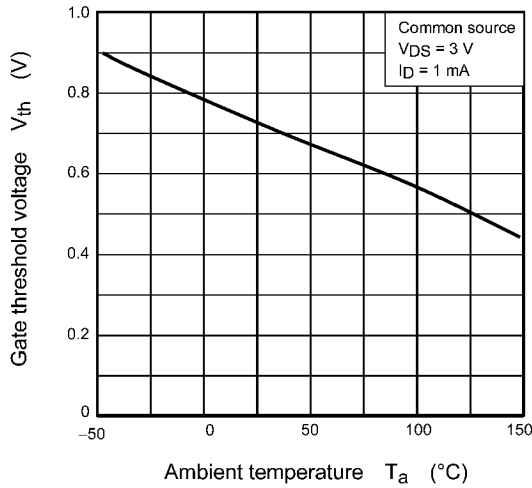
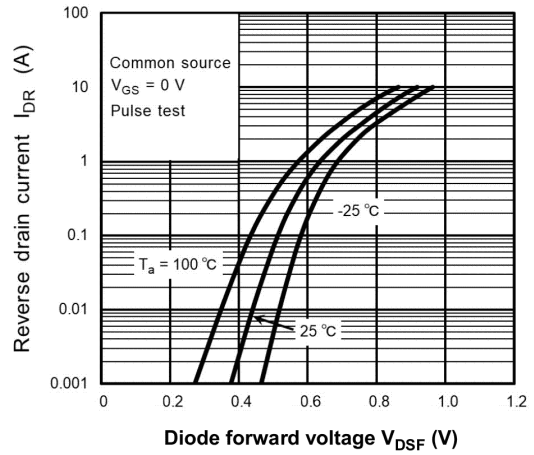


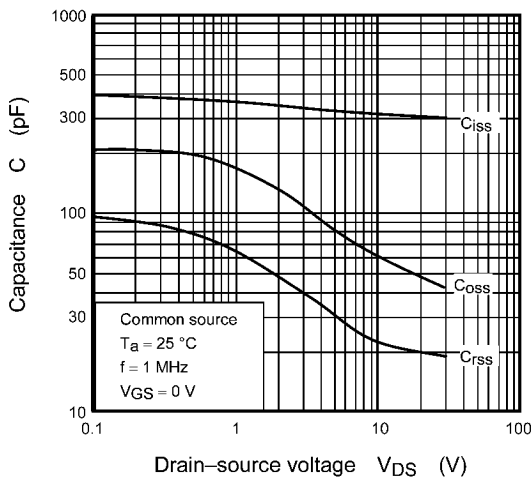
Fig. 8.1.6  $R_{DS(ON)} - T_a$



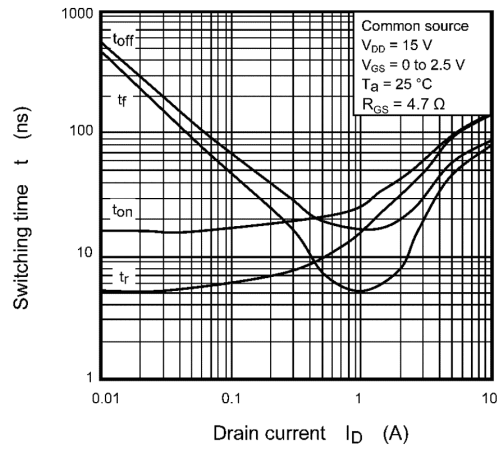
**Fig. 8.1.7  $V_{th} - T_a$**



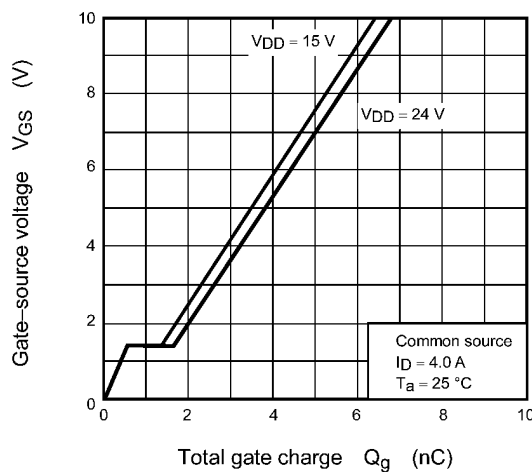
**Fig. 8.1.8  $I_{DR} - V_{DSF}$**



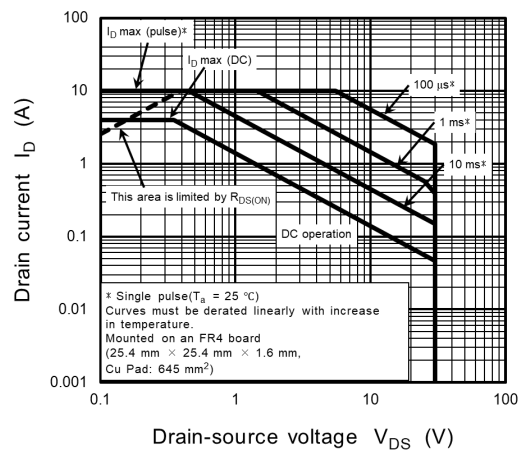
**Fig. 8.1.9  $C - V_{DS}$**



**Fig. 8.1.10  $t - I_D$**

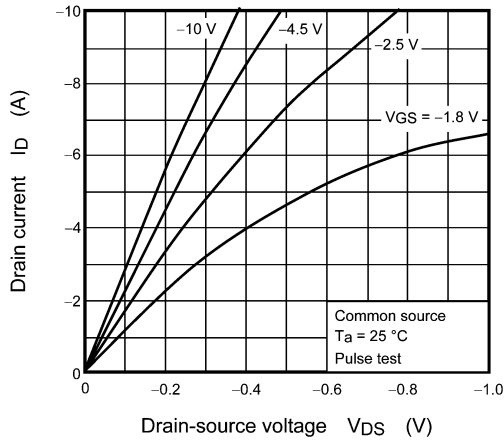


**Fig. 8.1.11 Dynamic Input Characteristics**

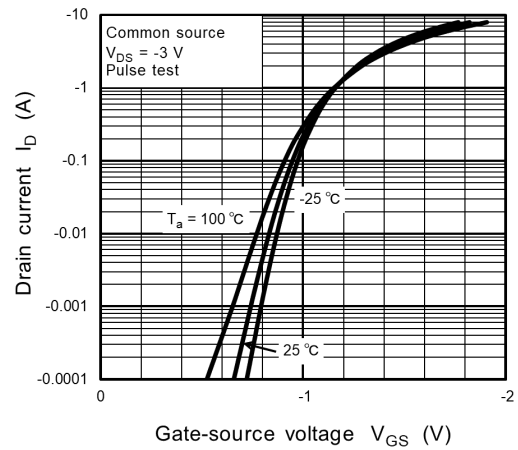


**Fig. 8.1.12 Safe Operating Area**

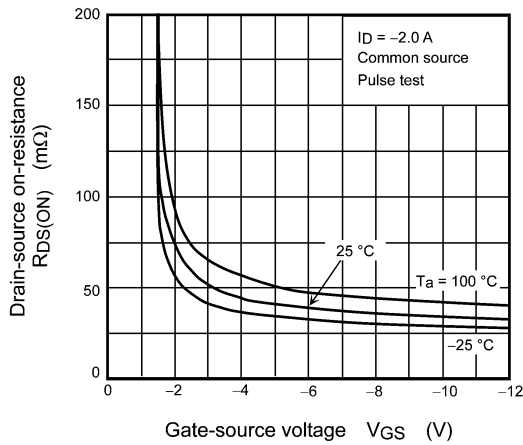
### 8.2. Q2 Characteristics Curves



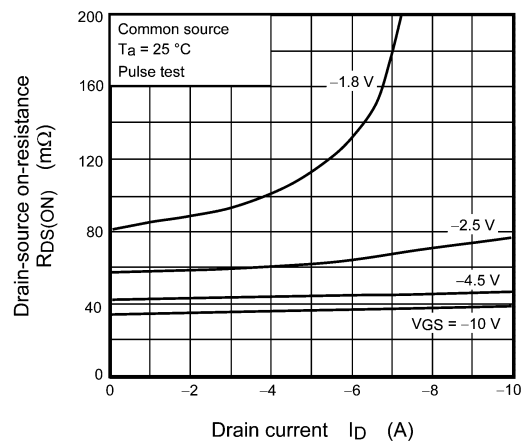
**Fig. 8.2.1  $I_D - V_{DS}$**



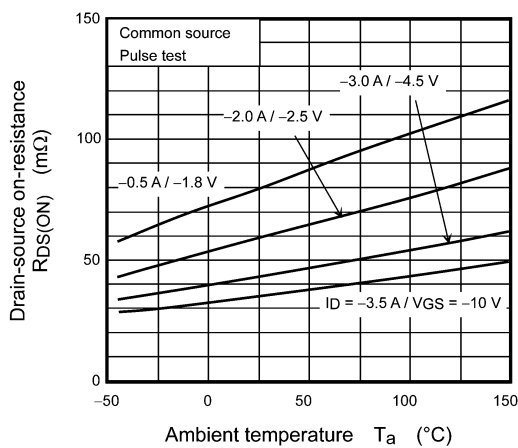
**Fig. 8.2.2  $I_D - V_{GS}$**



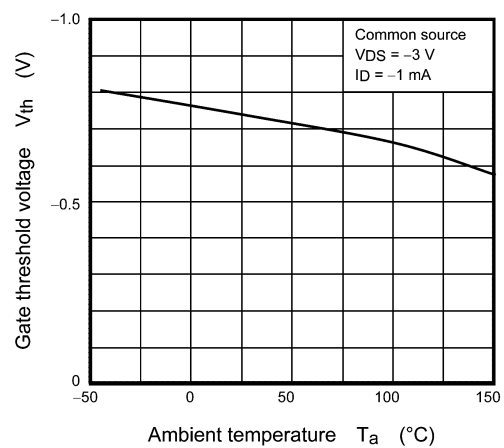
**Fig. 8.2.3  $R_{DS(ON)} - V_{GS}$**



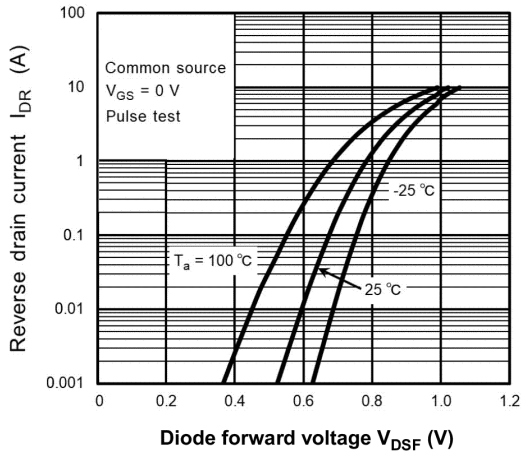
**Fig. 8.2.4  $R_{DS(ON)} - I_D$**



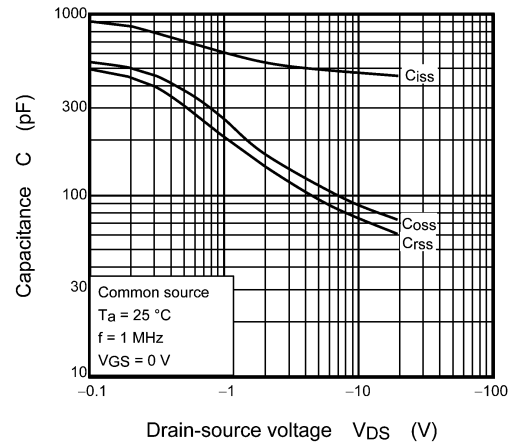
**Fig. 8.2.5  $R_{DS(ON)} - T_a$**



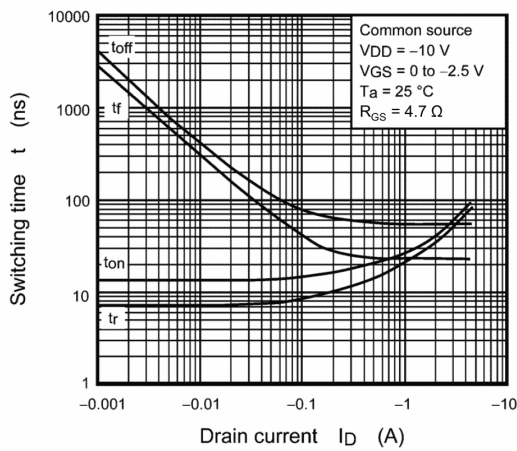
**Fig. 8.2.6  $V_{th} - T_a$**



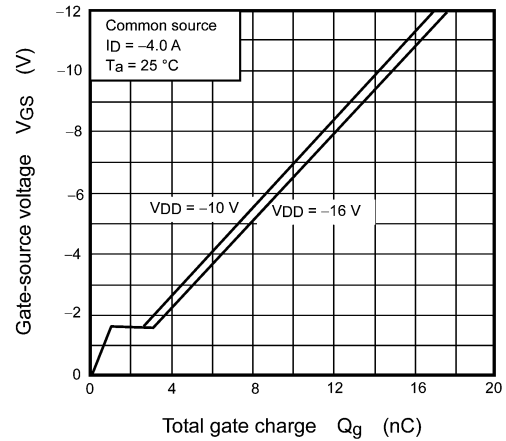
**Fig. 8.2.7  $I_{DR} - V_{DSF}$**



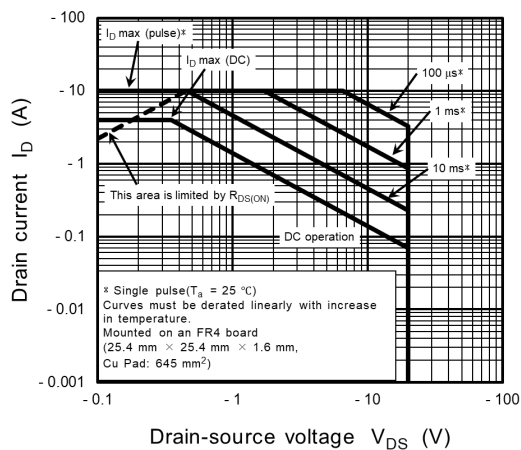
**Fig. 8.2.8  $C - V_{DS}$**



**Fig. 8.2.9  $t - I_D$**



**Fig. 8.2.10 Dynamic Input Characteristics**



**Fig. 8.2.11 Safe Operating Area**

### 8.3. Characteristics Curves (Q1, Q2 Common)

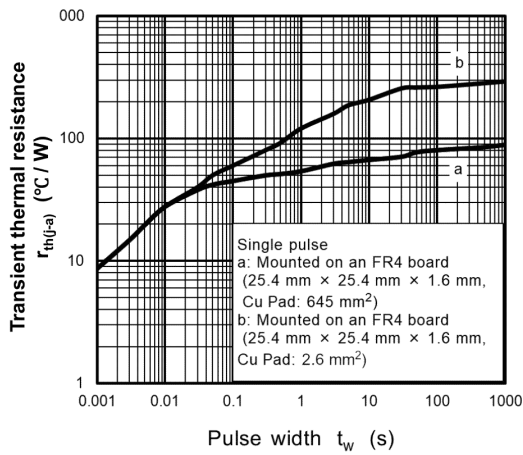


Fig. 8.3.1  $r_{th} - t_w$

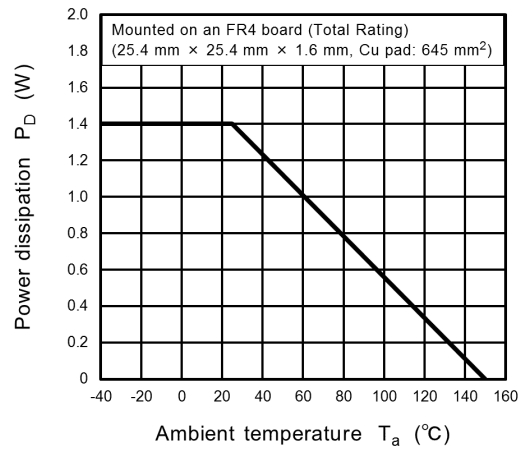
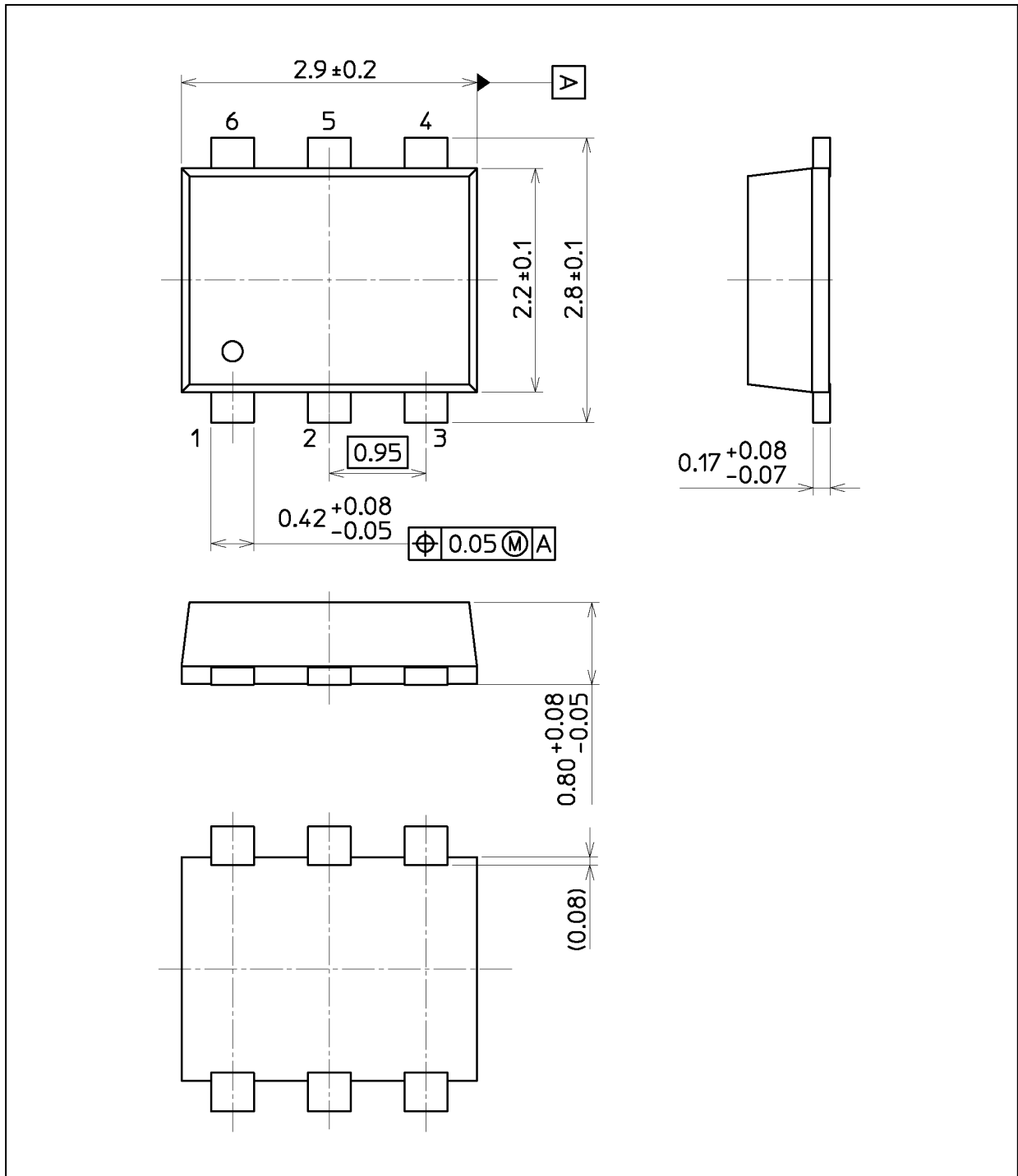


Fig. 8.3.2  $P_D - T_a$

Note: The above characteristics curves are presented for reference only and not guaranteed by production test, unless otherwise noted.

## Package Dimensions

Unit: mm



Weight: 0.016 g (typ.)

|                  |
|------------------|
| Package Name(s)  |
| Nickname: TSOP6F |

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